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April 2000

QFET™

FQB9N50 / FQI9N50

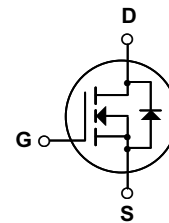
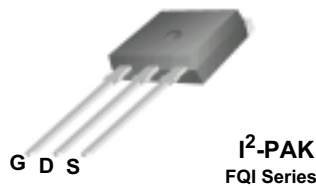
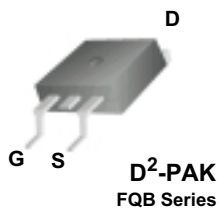
500V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply, power factor correction, electronic lamp ballast based on half bridge.

Features

- 9.0A, 500V, $R_{DS(on)} = 0.73\Omega @ V_{GS} = 10V$
- Low gate charge (typical 28 nC)
- Low Crss (typical 20 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

| Symbol | Parameter | FQB9N50 / FQI9N50 | Units |
|-----------------------------------|---|-------------------|-------|
| V _{DSS} | Drain-Source Voltage | 500 | V |
| I _D | Drain Current - Continuous (T _C = 25°C) | 9.0 | A |
| | - Continuous (T _C = 100°C) | 5.7 | A |
| I _{DM} | Drain Current - Pulsed (Note 1) | 36 | A |
| V _{GSS} | Gate-Source Voltage | ± 30 | V |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | 360 | mJ |
| I _{AR} | Avalanche Current (Note 1) | 9.0 | A |
| E _{AR} | Repetitive Avalanche Energy (Note 1) | 14.7 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | 4.5 | V/ns |
| P _D | Power Dissipation (T _A = 25°C) * | 3.13 | W |
| | Power Dissipation (T _C = 25°C) | 147 | W |
| | - Derate above 25°C | 1.18 | W/°C |
| T _J , T _{STG} | Operating and Storage Temperature Range | -55 to +150 | °C |
| T _L | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300 | °C |

Thermal Characteristics

| Symbol | Parameter | Typ | Max | Units |
|------------------|---|-----|------|-------|
| R _{θJC} | Thermal Resistance, Junction-to-Case | -- | 0.85 | °C/W |
| R _{θJA} | Thermal Resistance, Junction-to-Ambient * | -- | 40 | °C/W |
| R _{θJA} | Thermal Resistance, Junction-to-Ambient | -- | 62.5 | °C/W |

* When mounted on the minimum pad size recommended (PCB Mount)

Electrical Characteristics T_C = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------------------------------------|---|---|-----|------|------|-------|
| Off Characteristics | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} = 0 V, I _D = 250 μA | 500 | -- | -- | V |
| ΔBV _{DSS} / ΔT _J | Breakdown Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25°C | -- | 0.55 | -- | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 500 V, V _{GS} = 0 V | -- | -- | 1 | μA |
| | | V _{DS} = 400 V, T _C = 125°C | -- | -- | 10 | μA |
| I _{GSSF} | Gate-Body Leakage Current, Forward | V _{GS} = 30 V, V _{DS} = 0 V | -- | -- | 100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | V _{GS} = -30 V, V _{DS} = 0 V | -- | -- | -100 | nA |

| | | | | | | |
|---------------------------|-----------------------------------|---|-----|------|------|---|
| On Characteristics | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} = V _{GS} , I _D = 250 μA | 3.0 | -- | 5.0 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | V _{GS} = 10 V, I _D = 4.5 A | -- | 0.58 | 0.73 | Ω |
| g _{FS} | Forward Transconductance | V _{DS} = 50 V, I _D = 4.5 A (Note 4) | -- | 8.2 | -- | S |

| | | | | | | |
|--------------------------------|------------------------------|---|----|------|------|----|
| Dynamic Characteristics | | | | | | |
| C _{iss} | Input Capacitance | V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz | -- | 1100 | 1450 | pF |
| C _{oss} | Output Capacitance | | -- | 160 | 210 | pF |
| C _{rss} | Reverse Transfer Capacitance | | -- | 20 | 30 | pF |

| | | | | | | |
|----------------------------------|---------------------|--|---|------|-----|----|
| Switching Characteristics | | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 250 V, I _D = 9.0 A, R _G = 25 Ω (Note 4, 5) | -- | 25 | 60 | ns |
| t _r | Turn-On Rise Time | | -- | 95 | 200 | ns |
| t _{d(off)} | Turn-Off Delay Time | | -- | 55 | 120 | ns |
| t _f | Turn-Off Fall Time | | -- | 60 | 130 | ns |
| Q _g | Total Gate Charge | | V _{DS} = 400 V, I _D = 9.0 A, V _{GS} = 10 V (Note 4, 5) | -- | 28 | 36 |
| Q _{gs} | Gate-Source Charge | | -- | 7.0 | -- | nC |
| Q _{gd} | Gate-Drain Charge | | -- | 12.5 | -- | nC |

| | | | | | | |
|---|---|---|----|-----|-----|----|
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I _S | Maximum Continuous Drain-Source Diode Forward Current | | -- | -- | 9.0 | A |
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | -- | -- | 36 | A |
| V _{SD} | Drain-Source Diode Forward Voltage | V _{GS} = 0 V, I _S = 9.0 A | -- | -- | 1.4 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _S = 9.0 A, di _F / dt = 100 A/μs (Note 4) | -- | 300 | -- | ns |
| Q _{rr} | Reverse Recovery Charge | | -- | 2.2 | -- | μC |

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 8mH, I_{AS} = 9.0A, V_{DD} = 50V, R_G = 25 Ω, Starting T_J = 25°C
3. I_{SD} ≤ 9.0A, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Characteristics

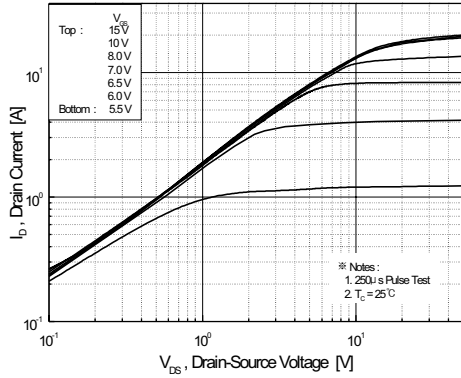


Figure 1. On-Region Characteristics

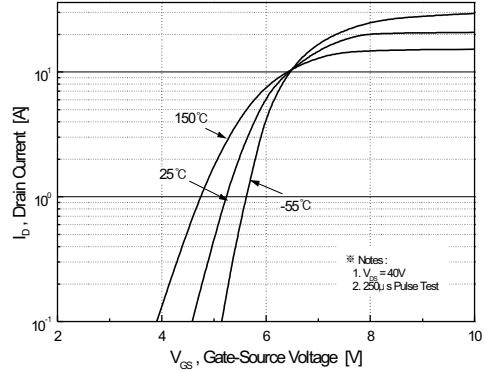


Figure 2. Transfer Characteristics

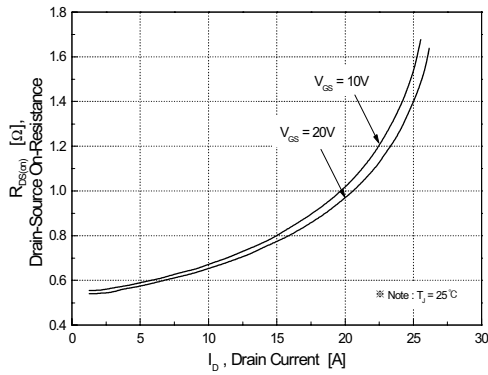


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

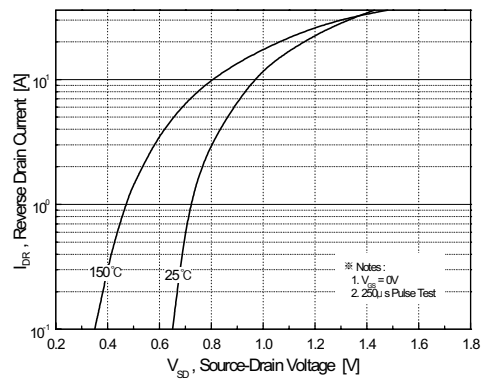


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

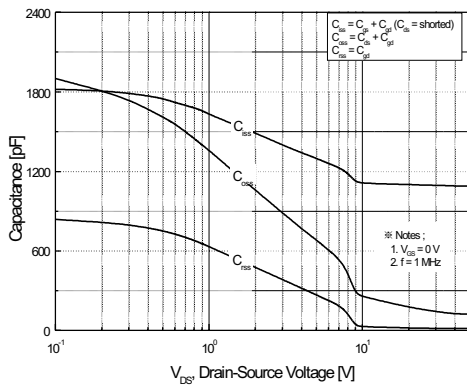


Figure 5. Capacitance Characteristics

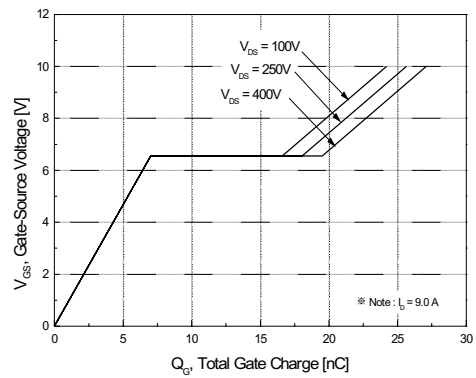


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

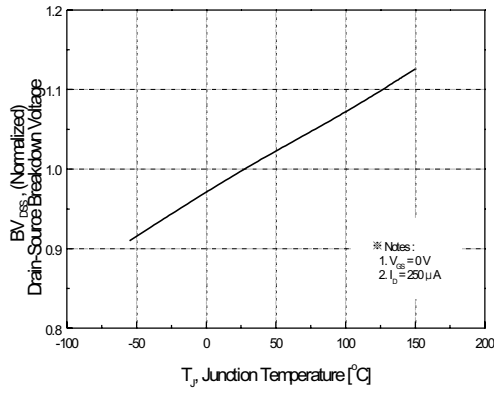


Figure 7. Breakdown Voltage Variation vs. Temperature

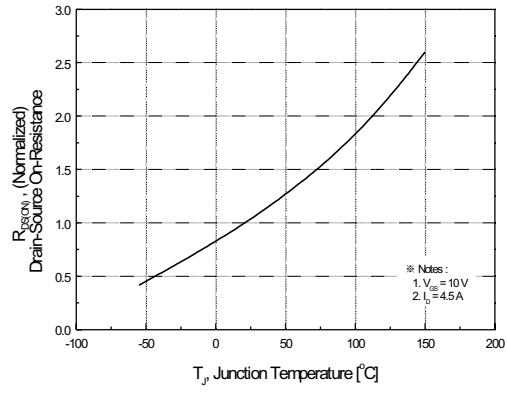


Figure 8. On-Resistance Variation vs. Temperature

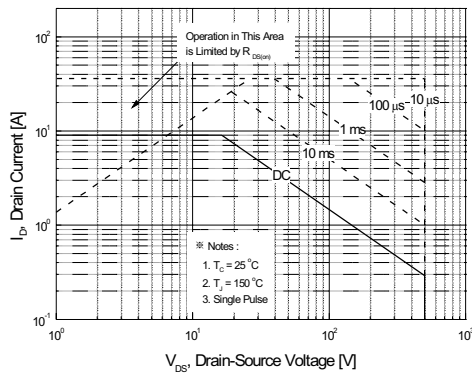


Figure 9. Maximum Safe Operating Area

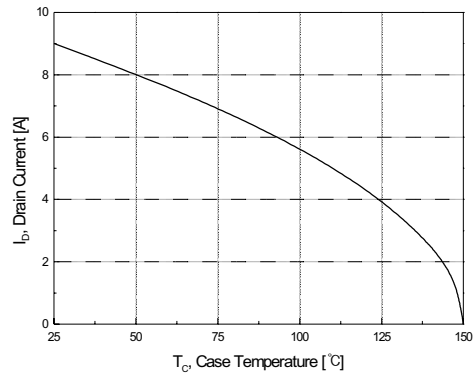


Figure 10. Maximum Drain Current vs. Case Temperature

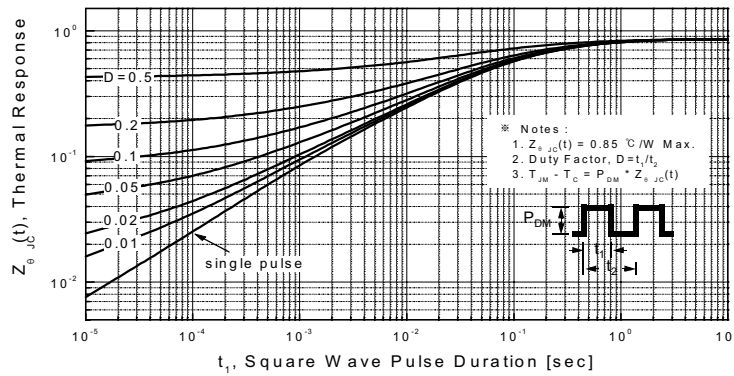
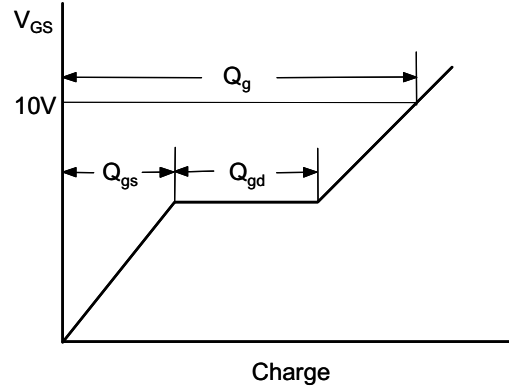
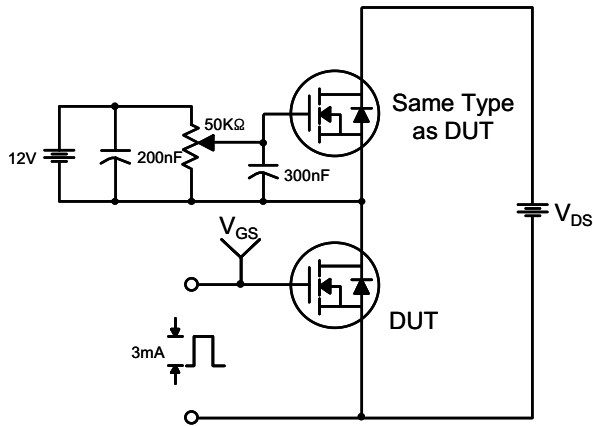
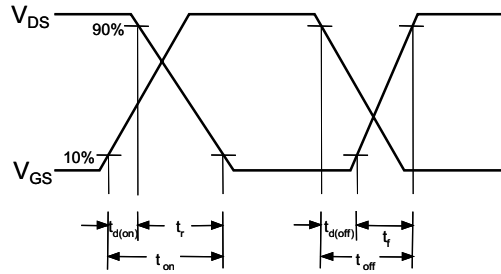
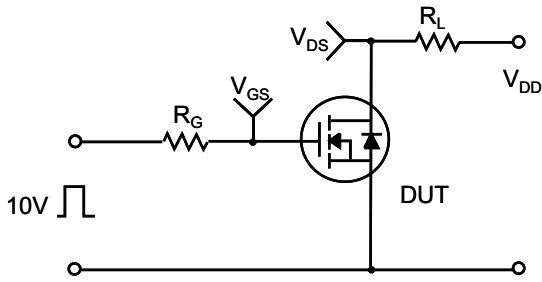


Figure 11. Transient Thermal Response Curve

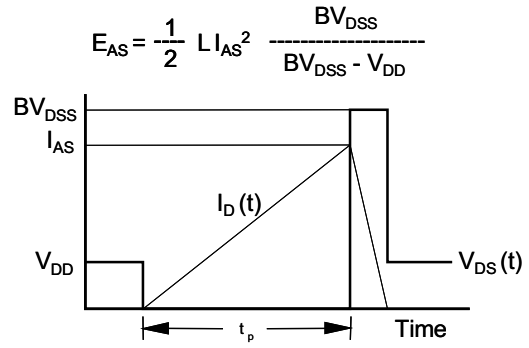
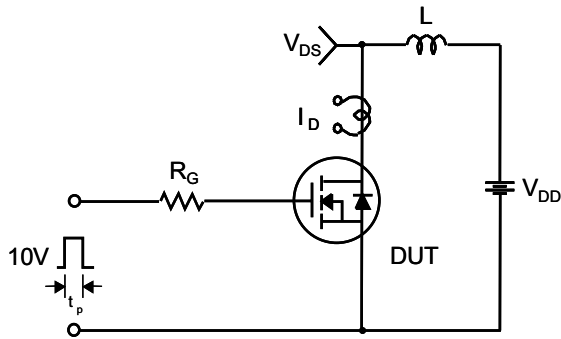
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

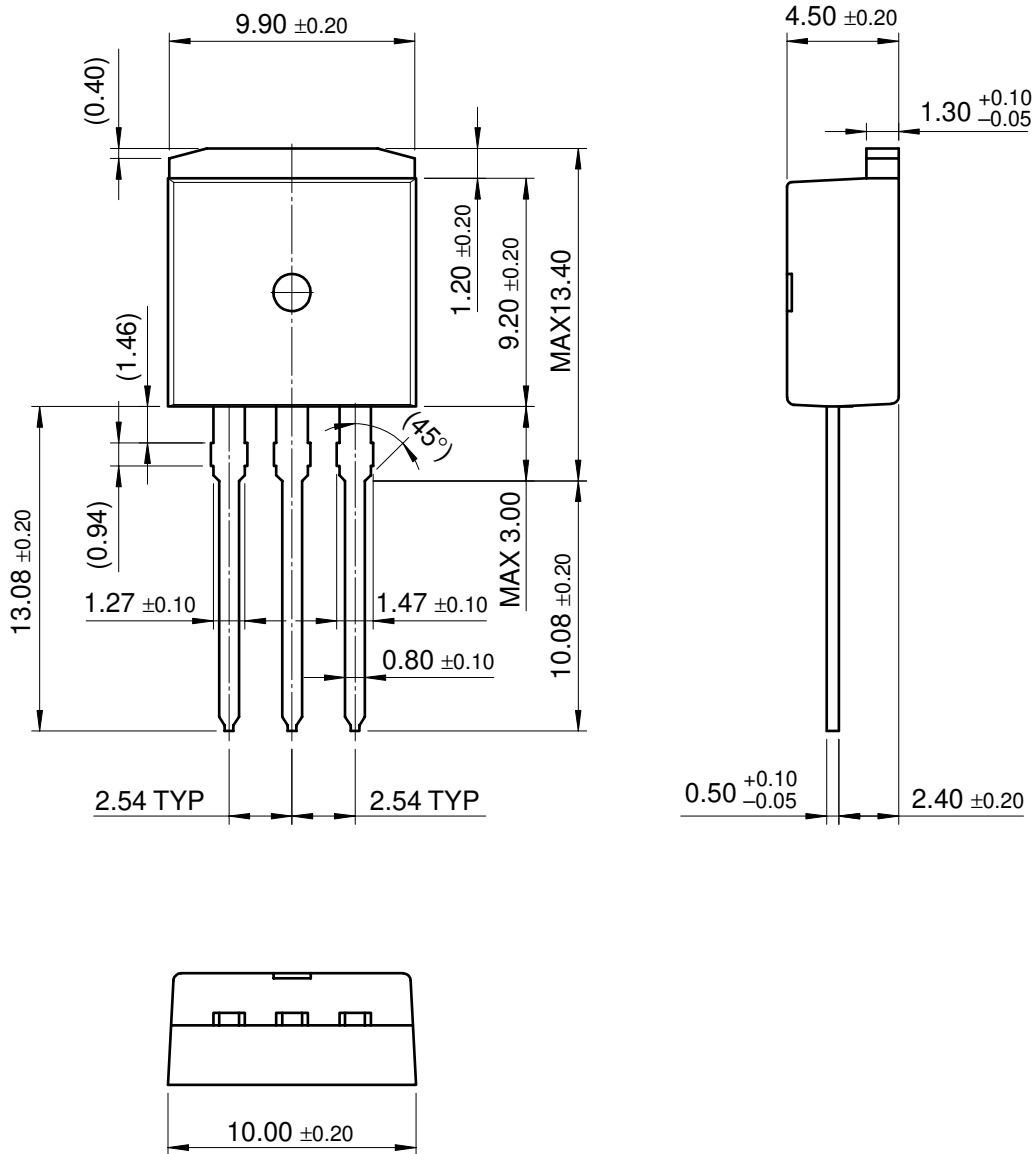


Unclamped Inductive Switching Test Circuit & Waveforms



Package Dimensions (Continued)

I²PAK



FQB9N50 / FQI9N50

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